

Search Notes**Application/Control No.**

10/565,740

**Applicant(s)/Patent under
Reexamination**

NEUMETZLER, HEIKO

Examiner

Hien D. Vu

Art Unit

2833

SEARCHED

Class	Subclass	Date	Examiner
439	404,405, 79,562, 751	7/2/2007	HV
Updated	Search	3/21/2008	HV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR